## Search Notes



Applicant(s)/Patent under Reexamination

3742

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Examiner
M. Alexandra Elve

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SEARCHED				
Class	Subclass	Date	Examiner	
update				
219	69.11	1/31/2009	MAE	
219	69.12	1/31/2009	MAE	
219	69.15	1/31/2009	MAE	
219	69.17	1/31/2009	MAE	
219	69.1	1/31/2009	MAE	

Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
(	DATE	EXMR	
update US OCR, US PAT, US PG, Derwent, JPO, EPO	1/31/2009	MAE	